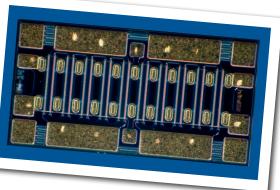


CGH80030D 30 W, 8.0 GHz, GaN HEMT Die

Cree's CGH80030D is a gallium nitride (GaN) High Electron Mobility Transistor (HEMT), based on Cree's 28V, 0.25um GaN-on-SiC process technology. GaN has superior properties compared to silicon or gallium arsenide, including higher breakdown voltage, higher saturated electron drift velocity, and higher thermal conductivity. GaN HEMTs offer greater power density and wider bandwidths compared to Si and GaAs transistors.



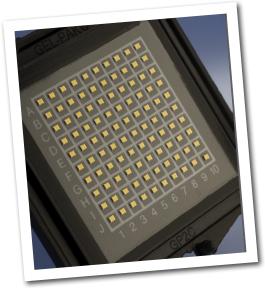
PN: CGH80030D

FEATURES

- 17 dB Typical Small Signal Gain at 4 GHz
- 12 dB Typical Small Signal Gain at 8 GHz
- 30 W Typical P_{SAT}
- 28 V Operation
- High Breakdown Voltage
- High Temperature Operation
- Up to 8 GHz Operation
- High Efficiency

APPLICATIONS

- 2-Way Private Radio
- Broadband Amplifiers
- Cellular Infrastructure
- Test Instrumentation
- Class A, AB, Linear amplifiers suitable for OFDM, W-CDMA, EDGE, CDMA waveforms



Packaging Information

- ROHS
- Bare die are shipped in Gel-Pak® containers.
- Non-adhesive tacky membrane immobilizes die during shipment.



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Absolute Maximum Ratings (not simultaneous) at 25°C

Parameter	Symbol	Rating	Units	Conditions
Drain-source Voltage	V _{DSS}	84	VDC	25°C
Gate-source Voltage	V _{GS}	-10, +2	VDC	25°C
Storage Temperature	T _{stg}	-65, +150	°C	
Operating Junction Temperature	Tj	225	°C	
Maximum Forward Gate Current	I _{GMAX}	7.0	mA	25°C
Maximum Drain Current ¹	I _{DMAX}	3.0	А	25°C
Thermal Resistance, Junction to Case (packaged) ²	R _{eJC}	4.9	°C/W	85°C, 28.8W Dissipation
Thermal Resistance, Junction to Case (die only)	R _{ejc}	2.74	°C/W	85°C, 28.8W Dissipation
Mounting Temperature (30 seconds)	Τ _s	320	°C	30 seconds

Note¹ Current limit for long term, reliable operation

Note² Eutectic die attach using 80/20 AuSn mounted to a 10 mil thick Cu15Mo85 carrier.

Electrical Characteristics (Frequency = 4 GHz unless otherwise stated; $T_c = 25^{\circ}C$)

		1				1			
Characteristics	Symbol	Min.	Тур.	Max.	Units	Conditions			
DC Characteristics									
Gate Threshold Voltage	$V_{\rm GS(TH)}$	-3.6	-3.0	-2.4	V	$V_{_{DS}}$ = 10 V, I _D = 7.2 mA			
Gate Quiescent Voltage	V _{GS(Q)}	-	-2.7	-	V _{DC}	$V_{_{DD}}$ = 28 V, I $_{_{DQ}}$ = 200 mA			
Drain-Source Breakdown Voltage	$V_{\rm BD}$	120	-	-	V	$V_{gg} = -8 \text{ V, I}_{D} = 7.2 \text{ mA}$			
On Resistance	R _{on}	0.26	0.33	0.41	Ω	V _{DS} = 0.1 V			
RF Characteristics									
Small Signal Gain	G _{ss}	-	16.5	-	dB	$V_{_{DD}}$ = 28 V, $I_{_{DQ}}$ = 200 mA			
Saturated Power Output ¹	P _{SAT}	-	30	-	w	V _{DD} = 28 V, I _{DQ} = 200 mA			
Drain Efficiency ²	η	-	65	-	%	$V_{_{\rm DD}}$ = 28 V, $I_{_{\rm DQ}}$ = 200 mA, $P_{_{\rm SAT}}$ = 30 W			
Output Mismatch Stress	VSWR	-	-	10:1	Y	No damage at all phase angles, V_{DD} = 28 V, I_{DQ} = 200 mA, P_{OUT} = 30 W CW			
Dynamic Characteristics									
Input Capacitance	C _{GS}	-	7.3	-	pF	$V_{_{DS}}$ = 28 V, $V_{_{gs}}$ = -8 V, f = 1 MHz			
Output Capacitance	C _{DS}	-	2.2	-	pF	$V_{_{DS}}$ = 28 V, $V_{_{gs}}$ = -8 V, f = 1 MHz			
Feedback Capacitance	C _{gd}	-	0.37	-	pF	$V_{_{DS}}$ = 28 V, $V_{_{gs}}$ = -8 V, f = 1 MHz			

Notes:

 1 P $_{\rm SAT}$ is defined as I $_{\rm G}$ = 0.7 mA.

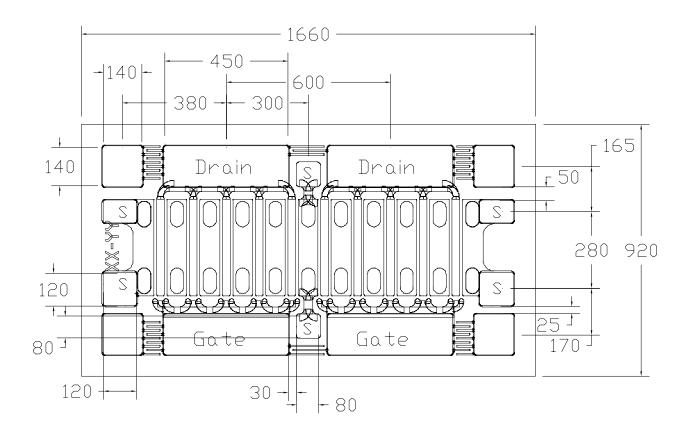
² Drain Efficiency = P_{OUT} / P_{DC} .

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DIE Dimensions (units in microns)



Overall die size 1660 x 920 (+0/-50) microns, die thickness 100 (+/- 10) microns. All Gate and Drain pads must be wire bonded for electrical connection.

Assembly Notes:

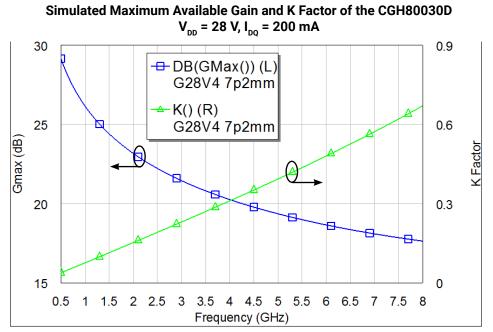
- Recommended solder is AuSn (80/20) solder. Refer to Cree's website for the Eutectic Die Bond Procedure application note at www.cree.com/RF/Document-Library
- Vacuum collet is the preferred method of pick-up.
- The backside of the die is the Source (ground) contact.
- Die back side gold plating is 5 microns thick minimum.
- Thermosonic ball or wedge bonding are the preferred connection methods.
- Gold wire must be used for connections.
- Use the die label (XX-YY) for correct orientation.

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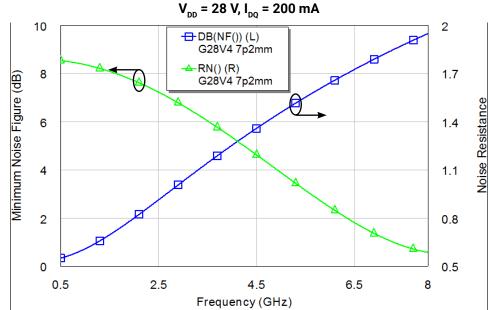


Typical Performance



Intrinsic die parameters - reference planes at centers of gate and drain bonding pads. No wire bonds assumed.

Typical Noise Performance



Simulated Minimum Noise Figure and Noise Resistance vs Frequency of the CGH80030D V_{pp} = 28 V, I_{pp} = 200 mA

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